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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/781,305	02/13/2001	Toshihiko Miyazaki	35.C15124	35.C15124 6389	
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FITZPATRICK CELLA HARPER & SCINTO			EXAMINER		
	30 ROCKEFELLER PLAZA NEW YORK, NY 10112		DONG, DALEI		
			ART UNIT	PAPER NUMBER	
			2875		
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Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)			
7	09/781,305	MIYAZAKI ET AL.			
Office Action Summary	Examiner	Art Unit			
	Dalei Dong	2875			
Th MAILING DATE of this communication app ars on the cov r she t with the correspondenc address Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).  - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).  Status					
1) Responsive to communication(s) filed on 10 A	<u> August 2003</u> .				
2a)⊠ This action is <b>FINAL</b> . 2b)□ Th	is action is non-final.				
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.  Disposition of Claims					
4) Claim(s) 1-78 is/are pending in the application.					
4a) Of the above claim(s) is/are withdrawn from consideration.					
5) Claim(s) is/are allowed.					
6)⊠ Claim(s) <u>1-78</u> is/are rejected.					
7) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction and/o	r election requirement.				
Application Papers					
9) The specification is objected to by the Examiner.					
10)⊠ The drawing(s) filed on 10 August 2003 is/are:	a) accepted or b) objected to by	y the Examiner.			
Applicant may not request that any objection to the					
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner.					
If approved, corrected drawings are required in reply to this Office action.					
12) The oath or declaration is objected to by the Examiner.					
Priority under 35 U.S.C. §§ 119 and 120					
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).					
a)⊠ All b)□ Some * c)□ None of:					
<ol> <li>☐ Certified copies of the priority document</li> </ol>	s have been received.				
2. Certified copies of the priority documents have been received in Application No. <u>09/781,305</u> .					
<ul> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>					
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).					
a) ☐ The translation of the foreign language provisional application has been received. 15)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.					
Attachment(s)					
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s)					

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#### **DETAILED ACTION**

### **Drawings**

New corrected drawings are required in this application because the loadlock in the newly submitted drawing is not formally drawn in. Applicant is advised to employ the services of a competent patent draftsperson outside the Office, as the U.S. Patent and Trademark Office no longer prepares new drawings. The corrected drawings are required in reply to the Office action to avoid abandonment of the application. The requirement for corrected drawings will not be held in abeyance.

## Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-78 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent No. 5,433,639 to Zahuta in view of U.S. Patent No. 6,004,181 to Robinson.

Regarding to claims 1-20, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92,

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numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

Zahuta also discloses in Figure 3, "as a separate operation, preferably conducted in parallel with the preceding steps, the non-evaporative getter 50 for the dewar is placed, numeral 70, into a second vacuum chamber 110 that interconnects to the assembly chamber 108 through a fifth vacuum lock 112. The second vacuum chamber 110 is evacuated, numeral 72. The getter material is activated, numeral 74, by heating the getter material to a temperature of up to about 900 degree. C. for 10 minutes using electrodes, resistive heaters, radio frequency induction heaters, or other operable heating device.

After completion of the activating, the getter material is moved to the assembly chamber 108 through the fifth vacuum lock 112 (heat shielding member)" (column 6, line 8-20).

Zahuta further discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

Zahuta further yet discloses in Figure 3, "in the vacuum joining chamber 114, the assembled components are joined permanently or semipermanently using any appropriate technique, numeral 78. Examples of joining techniques include a metal gasket placed between the components, an O-ring gasket placed between the components, cold metal welding of the components, electron beam welding, and laser welding. FIG. 2 shows

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only a single assembly chamber 108 and a single joining chamber 114, but there could be others as appropriate for the particular type of dewar assembly. For example, it might be appropriate to electron beam weld two particular components together, so a first joining chamber could be provided with an electron beam welder. Two other components might be more properly joined using laser welding, and a second joining chamber would be provided with a laser welder. The various parts and subassemblies to be joined would be moved to the appropriate joining chambers" (column 6, line 29-46).

However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed. Robinson teaches, "the face plate 2 is the element containing phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the emitters and the extraction gates even though they are not shown. The seal ring 4 is shaped such that it will match up with the border of the face plate and substrate. It will be appreciated that the seal ring 4 can take any form such as circular or rectangular, as long as the seal ring 4 matches the shape of the face plate 2 and the substrate 6. Thus, when the face plate 2 is lowered and the substrate 6 raised with sufficient pressure to ensure uniform adhesion to the face plate and substrate 6 by the seal ring 4, a volume is formed bordered by the walls of the seal ring 4, the face plate 2, and the substrate 6" (column 2, line 54-67).

Zahuta in view of Robinson discloses the claimed invention except for each of the chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. It is old and well known in the art to evacuated the chamber as much as possible in order to reduce the impurities within the display device. It would have been obvious to one having ordinary skill in the

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art at the time the invention was made to evacuate the chamber to the desired pressure in accordance to the need of the display device, since it has been held that where the general conditions of a claim are disclosed in the prior, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233. Furthermore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

Regarding to claims 21-38, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92, numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

Zahuta also discloses in Figure 3, "After cleaning, many of the parts and components are baked in vacuum, numeral 69, in the third subchamber 98. The bakeout temperature is typically up to about 250 degree. C. In this case, only a single bakeout subchamber 98 is shown, but there could be additional such subchambers. The bakeout removes additional adsorbed contaminants from the surfaces of the parts and components. After bakeout is complete, the parts and components are moved to the assembly chamber 108" (column 5, line 63-68 to column 6, line 1-3).

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Zahuta further discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

Zahuta further yet discloses in Figure 3, "in the vacuum joining chamber 114, the assembled components are joined permanently or semipermanently using any appropriate technique, numeral 78. Examples of joining techniques include a metal gasket placed between the components, an O-ring gasket placed between the components, cold metal welding of the components, electron beam welding, and laser welding. FIG. 2 shows only a single assembly chamber 108 and a single joining chamber 114, but there could be others as appropriate for the particular type of dewar assembly. For example, it might be appropriate to electron beam weld two particular components together, so a first joining chamber could be provided with an electron beam welder. Two other components might be more properly joined using laser welding, and a second joining chamber would be provided with a laser welder. The various parts and subassemblies to be joined would be moved to the appropriate joining chambers" (column 6, line 29-46).

However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed. Robinson teaches, "the face plate 2 is the element containing phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the emitters and the extraction gates even though they are not shown.

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The seal ring 4 is shaped such that it will match up with the border of the face plate and substrate. It will be appreciated that the seal ring 4 can take any form such as circular or rectangular, as long as the seal ring 4 matches the shape of the face plate 2 and the substrate 6. Thus, when the face plate 2 is lowered and the substrate 6 raised with sufficient pressure to ensure uniform adhesion to the face plate and substrate 6 by the seal ring 4, a volume is formed bordered by the walls of the seal ring 4, the face plate 2, and the substrate 6" (column 2, line 54-67).

Zahuta in view of Robinson discloses the claimed invention except for each of the chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. It is old and well known in the art to evacuated the chamber as much as possible in order to reduce the impurities within the display device. It would have been obvious to one having ordinary skill in the art at the time the invention was made to evacuate the chamber to the desired pressure in accordance to the need of the display device, since it has been held that where the general conditions of a claim are disclosed in the prior, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233. Furthermore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

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Regarding to claims 39-58, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92, numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

Zahuta also discloses in Figure 3, "after cleaning, many of the parts and components are baked in vacuum, numeral 69, in the third subchamber 98. The bakeout temperature is typically up to about 250 degree. C. In this case, only a single bakeout subchamber 98 is shown, but there could be additional such subchambers. The bakeout removes additional adsorbed contaminants from the surfaces of the parts and components. After bakeout is complete, the parts and components are moved to the assembly chamber 108" (column 5, line 63-68 to column 6, line 1-3).

Zahuta further discloses in Figure 3, "as a separate operation, preferably conducted in parallel with the preceding steps, the non-evaporative getter 50 for the dewar is placed, numeral 70, into a second vacuum chamber 110 that interconnects to the assembly chamber 108 through a fifth vacuum lock 112. The second vacuum chamber 110 is evacuated, numeral 72. The getter material is activated, numeral 74, by heating the getter material to a temperature of up to about 900 degree. C. for 10 minutes using electrodes, resistive heaters, radio frequency induction heaters, or other operable heating device. After completion of the activating, the getter material is moved to the assembly

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chamber 108 through the fifth vacuum lock 112 (heat shielding member)" (column 6, line 8-20).

Zahuta further yet discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

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However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed. Robinson teaches, "the face plate 2 is the element containing

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phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the emitters and the extraction gates even though they are not shown. The seal ring 4 is shaped such that it will match up with the border of the face plate and substrate. It will be appreciated that the seal ring 4 can take any form such as circular or rectangular, as long as the seal ring 4 matches the shape of the face plate 2 and the substrate 6. Thus, when the face plate 2 is lowered and the substrate 6 raised with sufficient pressure to ensure uniform adhesion to the face plate and substrate 6 by the seal ring 4, a volume is formed bordered by the walls of the seal ring 4, the face plate 2, and the substrate 6" (column 2, line 54-67).

Zahuta in view of Robinson discloses the claimed invention except for each of the chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. It is old and well known in the art to evacuated the chamber as much as possible in order to reduce the impurities within the display device. It would have been obvious to one having ordinary skill in the art at the time the invention was made to evacuate the chamber to the desired pressure in accordance to the need of the display device, since it has been held that where the general conditions of a claim are disclosed in the prior, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233. Furthermore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

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Regarding to claims 59-78, Zahuta discloses in Figure 3, "A gas-tight first vacuum lock 100 provides external access to the first vacuum chamber 92. A gas-tight second vacuum lock 102 separates the first sub chamber 94 from the second subchamber 96. A gas-tight third vacuum lock 104 separates the second subchamber 96 from the third subchamber 98. A gas-tight fourth vacuum lock 106 separates the third subchamber 98 from an evacuated assembly chamber 108. The fourth vacuum lock 106 thus provides external access to the first vacuum chamber 92 at the end opposite the first vacuum lock 100" (column 5, line 23-33).

Zahuta also discloses in Figure 3, "each of the subchambers can be isolated from the other subchambers, the external environment, and the downstream assembly chamber. Each subchamber can therefore be evacuated separately from the others. An important advantage of this process is the capability to prevent contaminants produced during the processing in one of the subchambers to reach the other subchambers" (column 5, line 34-41).

Zahuta further discloses in Figure 3, "contaminants are removed from the parts and subassemblies, numeral 68. In the illustrated processing system 90, two cleaning stages are provided for illustration. There may be multiple cleaning stages because some parts and subassemblies may require different cleaning than other parts and subassemblies, and the present approach gives complete flexibility in this regard.

Examples of types of cleaning operations that may be used in vacuum include plasma glow discharge cleaning, ultraviolet photon stimulated desorption, infrared heating,

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ultraviolet cleaning, and ion bombardment, all of which are known in the art. Again by way of example, the first sub chamber 94 might be provided with the apparatus for performing ultraviolet cleaning and the second subchamber 96 might be provided with the apparatus for performing ion bombardment. Some parts or subassemblies might be most effectively cleaned by one process but should not be exposed to the other. In these cases, the parts or subassemblies are loaded into the cleaning subchamber 94 or 96 that is appropriate for it" (column 5, line 42-62).

However, Zahuta does not disclose a second getter-processing chamber. It would have been obvious to one of ordinary skill in the art at the time the invention was made to have add another getter processing chamber in order to further remove the contaminants from parts and subassemblies and to accommodate the needs and requirement of different gettering process of different parts and subassemblies. Also, Zahuta in view of Robinson discloses the claimed invention except for each of the chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. It is old and well known in the art to evacuated the chamber as much as possible in order to reduce the impurities within the display device. It would have been obvious to one having ordinary skill in the art at the time the invention was made to evacuate the chamber to the desired pressure in accordance to the need of the display device, since it has been held that where the general conditions of a claim are disclosed in the prior, discovering the optimum or workable ranges involves only routine skill in the art. In re Aller, 105 USPQ 233. Furthermore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta for the phosphor containing faceplate and the emitter

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containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

4. Claims 1-78 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent No. 5,433,639 to Zahuta in view of U.S. Patent No. 6,004,181 to Robinson in further view of U.S. Patent No. 5,564,958 to Itoh.

Regarding to claims 1-20, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92, numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

Zahuta also discloses in Figure 3, "as a separate operation, preferably conducted in parallel with the preceding steps, the non-evaporative getter 50 for the dewar is placed, numeral 70, into a second vacuum chamber 110 that interconnects to the assembly chamber 108 through a fifth vacuum lock 112. The second vacuum chamber 110 is evacuated, numeral 72. The getter material is activated, numeral 74, by heating the getter material to a temperature of up to about 900 degree. C. for 10 minutes using electrodes, resistive heaters, radio frequency induction heaters, or other operable heating device.

After completion of the activating, the getter material is moved to the assembly chamber 108 through the fifth vacuum lock 112 (heat shielding member)" (column 6, line 8-20).

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Zahuta further discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

Zahuta further yet discloses in Figure 3, "in the vacuum joining chamber 114, the assembled components are joined permanently or semipermanently using any appropriate technique, numeral 78. Examples of joining techniques include a metal gasket placed between the components, an O-ring gasket placed between the components, cold metal welding of the components, electron beam welding, and laser welding. FIG. 2 shows only a single assembly chamber 108 and a single joining chamber 114, but there could be others as appropriate for the particular type of dewar assembly. For example, it might be appropriate to electron beam weld two particular components together, so a first joining chamber could be provided with an electron beam welder. Two other components might be more properly joined using laser welding, and a second joining chamber would be provided with a laser welder. The various parts and subassemblies to be joined would be moved to the appropriate joining chambers" (column 6, line 29-46).

However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed and the each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Robinson teaches, "the face plate 2 is the element containing phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the

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However, Robinson does not teach each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Itoh teaches in Figure 1, "Introduction of the reducing gas and evacuation of the reducing gas described above are repeated to 10 times or less, for example, 8 times. Then, the display device 2 is subject to evacuation for about 6 hours while keeping an interior of the chamber at about 300 degree. C., resulting in a pressure in the display device 2 being reduced to a level as low as about 10 sup.-7 Torr, followed by sealing of the evacuation tube or a sealing lid, so that the display device 2 may be kept at a high <u>vacuum</u>" (column 4, line 64 to column 5, line 5).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta with the vacuum pressure of Itoh for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

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Regarding to claims 21-38, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92, numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

Zahuta also discloses in Figure 3, "After cleaning, many of the parts and components are baked in vacuum, numeral 69, in the third subchamber 98. The bakeout temperature is typically up to about 250.degree. C. In this case, only a single bakeout subchamber 98 is shown, but there could be additional such subchambers. The bakeout removes additional adsorbed contaminants from the surfaces of the parts and components. After bakeout is complete, the parts and components are moved to the assembly chamber 108" (column 5, line 63-68 to column 6, line 1-3).

Zahuta further discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

Zahuta further yet discloses in Figure 3, "in the vacuum joining chamber 114, the assembled components are joined permanently or semipermanently using any appropriate

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between the components, an O-ring gasket placed between the components, cold metal welding of the components, electron beam welding, and laser welding. FIG. 2 shows only a single assembly chamber 108 and a single joining chamber 114, but there could be others as appropriate for the particular type of dewar assembly. For example, it might be appropriate to electron beam weld two particular components together, so a first joining chamber could be provided with an electron beam welder. Two other components might be more properly joined using laser welding, and a second joining chamber would be provided with a laser welder. The various parts and subassemblies to be joined would be moved to the appropriate joining chambers" (column 6, line 29-46).

However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed and each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Robinson teaches, "the face plate 2 is the element containing phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the emitters and the extraction gates even though they are not shown. The seal ring 4 is shaped such that it will match up with the border of the face plate and substrate. It will be appreciated that the seal ring 4 can take any form such as circular or rectangular, as long as the seal ring 4 matches the shape of the face plate 2 and the substrate 6. Thus, when the face plate 2 is lowered and the substrate 6 raised with sufficient pressure to ensure uniform adhesion to the face plate and substrate 6 by the seal ring 4, a volume is formed bordered by the walls of the seal ring 4, the face plate 2, and the substrate 6" (column 2, line 54-67).

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It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta with the vacuum pressure of Itoh for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

Regarding to claims 39-58, Zahuta discloses in Figure 3, "a processing system 90 is provided. The processing system 90 includes multiple vacuum chambers which are discussed in terms of their functions. A first vacuum chamber 92 is provided, numeral 62. The parts and subassemblies are placed or loaded into the first vacuum chamber 92, numeral 64, and the first vacuum chamber is sealed and evacuated using a vacuum pump, numeral 66" (column 5, line 3-10).

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Zahuta further discloses in Figure 3, "as a separate operation, preferably conducted in parallel with the preceding steps, the non-evaporative getter 50 for the dewar is placed, numeral 70, into a second vacuum chamber 110 that interconnects to the assembly chamber 108 through a fifth vacuum lock 112. The second vacuum chamber 110 is evacuated, numeral 72. The getter material is activated, numeral 74, by heating the getter material to a temperature of up to about 900 degree. C. for 10 minutes using electrodes, resistive heaters, radio frequency induction heaters, or other operable heating device. After completion of the activating, the getter material is moved to the assembly chamber 108 through the fifth vacuum lock 112 (heat shielding member)" (column 6, line 8-20).

Zahuta further yet discloses in Figure 3, "in the assembly chamber 108, the parts, subassemblies, and getter are assembled together, numeral 76. Assembly may be accomplished by any of a variety of techniques, including for example robotic assembly, other fully or partially automated assembly, or manual assembly as by using

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manipulators. The assembly is moved to a vacuum joining chamber 114 through a sixth vacuum lock 116 (load lock)" (column 6, line 21-28).

Zahuta further yet discloses in Figure 3, "in the vacuum joining chamber 114, the assembled components are joined permanently or semipermanently using any appropriate technique, numeral 78. Examples of joining techniques include a metal gasket placed between the components, an O-ring gasket placed between the components, cold metal welding of the components, electron beam welding, and laser welding. FIG. 2 shows only a single assembly chamber 108 and a single joining chamber 114, but there could be others as appropriate for the particular type of dewar assembly. For example, it might be appropriate to electron beam weld two particular components together, so a first joining chamber could be provided with an electron beam welder. Two other components might be more properly joined using laser welding, and a second joining chamber would be provided with a laser welder. The various parts and subassemblies to be joined would be moved to the appropriate joining chambers" (column 6, line 29-46).

However, Zahuta does not disclose a first substrate on which phosphor exciting means is disposed and each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Robinson teaches, "the face plate 2 is the element containing phosphorus which emits light when struck by electrons. It is also understood that the substrate comprises the emitters and the extraction gates even though they are not shown. The seal ring 4 is shaped such that it will match up with the border of the face plate and substrate. It will be appreciated that the seal ring 4 can take any form such as circular or rectangular, as long as the seal ring 4 matches the shape of the face plate 2 and the substrate 6. Thus,

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when the face plate 2 is lowered and the substrate 6 raised with sufficient pressure to ensure uniform adhesion to the face plate and substrate 6 by the seal ring 4, a volume is formed bordered by the walls of the seal ring 4, the face plate 2, and the substrate 6" (column 2, line 54-67).

However, Robinson does not teach each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Itoh teaches in Figure 1, "Introduction of the reducing gas and evacuation of the reducing gas described above are repeated to 10 times or less, for example, 8 times. Then, the display device 2 is subject to evacuation for about 6 hours while keeping an interior of the chamber at about 300 degree. C., resulting in a pressure in the display device 2 being reduced to a level as low as about 10 sup.-7 Torr, followed by sealing of the evacuation tube or a sealing lid, so that the display device 2 may be kept at a high vacuum" (column 4, line 64 to column 5, line 5).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta with the vacuum pressure of Itoh for the phosphor containing faceplate and the emitter containing substrate of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

Regarding to claims 59-78, Zahuta discloses in Figure 3, "A gas-tight first vacuum lock 100 provides external access to the first vacuum chamber 92. A gas-tight second vacuum lock 102 separates the first sub chamber 94 from the second subchamber

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96. A gas-tight third vacuum lock 104 separates the second subchamber 96 from the third subchamber 98. A gas-tight fourth vacuum lock 106 separates the third subchamber 98 from an evacuated assembly chamber 108. The fourth vacuum lock 106 thus provides external access to the first vacuum chamber 92 at the end opposite the first vacuum lock 100" (column 5, line 23-33).

Zahuta also discloses in Figure 3, "each of the subchambers can be isolated from the other subchambers, the external environment, and the downstream assembly chamber. Each subchamber can therefore be evacuated separately from the others. An important advantage of this process is the capability to prevent contaminants produced during the processing in one of the subchambers to reach the other subchambers" (column 5, line 34-41).

Zahuta further discloses in Figure 3, "contaminants are removed from the parts and subassemblies, numeral 68. In the illustrated processing system 90, two cleaning stages are provided for illustration. There may be multiple cleaning stages because some parts and subassemblies may require different cleaning than other parts and subassemblies, and the present approach gives complete flexibility in this regard. Examples of types of cleaning operations that may be used in vacuum include plasma glow discharge cleaning, ultraviolet photon stimulated desorption, infrared heating, ultraviolet cleaning, and ion bombardment, all of which are known in the art. Again by way of example, the first sub chamber 94 might be provided with the apparatus for performing ultraviolet cleaning and the second subchamber 96 might be provided with the apparatus for performing ion bombardment. Some parts or subassemblies might be

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most effectively cleaned by one process but should not be exposed to the other. In these cases, the parts or subassemblies are loaded into the cleaning subchamber 94 or 96 that is appropriate for it" (column 5, line 42-62).

However, Zahuta does not disclose a second getter-processing chamber and each chamber is evacuated into 10<sup>-4</sup> Pa or more lower pressure. Itoh teaches in Figure 1, "Introduction of the reducing gas and evacuation of the reducing gas described above are repeated to 10 times or less, for example, 8 times. Then, the display device 2 is subject to evacuation for about 6 hours while keeping an interior of the chamber at about 300.degree. C., resulting in a <u>pressure</u> in the display device 2 being reduced to a level as low as about 10.sup.-7 Torr, followed by sealing of the evacuation tube or a sealing lid, so that the display device 2 may be kept at a high <u>vacuum</u>" (column 4, line 64 to column 5, line 5).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have utilize method of manufacturing of Zahuta with the vacuum pressure of Itoh for the phosphor containing faceplate and the emitter containing substrate of Robinson and further to add another getter processing chamber in order to further remove the contaminants from parts and subassemblies and to accommodate the needs and requirement of different gettering process of different parts and subassemblies and increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device.

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# Response to Arguments

5. Applicant's arguments with respect to claims 1-78 have been considered but are moot in view of the new ground(s) of rejection.

However, in response to applicant's argument that there is no suggestion to combine the references, the examiner recognizes that obviousness can only be established by combining or modifying the teachings of the prior art to produce the claimed invention where there is some teaching, suggestion, or motivation to do so found either in the references themselves or in the knowledge generally available to one of ordinary skill in the art. See In re Fine, 837 F.2d 1071, 5 USPQ2d 1596 (Fed. Cir. 1988) and In re Jones, 958 F.2d 347, 21 USPQ2d 1941 (Fed. Cir. 1992). In this case, Zahuta reference disclsoess a method of manufacturing a housing or a vacuum chamber for various display devices and Robinson reference teaches display device and a method of manufacturing thereof and a vacuum housing is utilized for the display of Robinson, therefore it would have been obvious to one having ordinary skill in the art at the time the invention was made to have utilize the method of manufacturing of Zahuta for the display device of Robinson in order to increased the high vacuum for the device and improve the efficiency of the electron emitted and thus improve the overall performance and prolong the lifetime of the device. Thus, Examiner asserts that the combination of Zahuta reference with Robinson reference is valid.

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#### Conclusion

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6. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dalei Dong whose telephone number is (703)308-2870. The examiner can normally be reached on 8 A.M. to 5 P.M..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Sandra O'Shea can be reached on (703)305-4939. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703)308-0956.

D.D.

August 27, 2003

Salidra O'Shea

Supervisory Patent Examiner Technology Center 2800